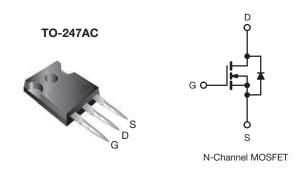
Vishay Siliconix

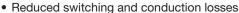
## **EL Series Power MOSFET**



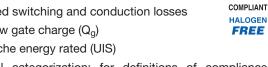
PRODUCT SUMMARY					
V <sub>DS</sub> (V) at T <sub>J</sub> max.	650				
R <sub>DS(on)</sub> typ. (Ω) at 25 °C	V <sub>GS</sub> = 10 V	0.035			
Q <sub>g</sub> max. (nC)	342				
Q <sub>gs</sub> (nC)	34				
Q <sub>gd</sub> (nC)	5	7			
Configuration	Sin	gle			

#### **FEATURES**

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)



- Ultra low gate charge (Q<sub>a</sub>)
- Avalanche energy rated (UIS)
- · Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



### **APPLICATIONS**

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Industrial
  - Welding
  - Induction heating
  - Motor drives
  - Battery chargers
  - Renewable energy
  - Solar (PV inverters)

ORDERING INFORMATION	
Package	TO-247AC
Lead (Pb)-free and halogen-free	SiHG73N60AEL-GE3

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			$V_{DS}$	600		
Gate-source voltage			$V_{GS}$	± 30	V	
Continuous drain current (T <sub>J</sub> = 150 °C)		\/ at 10 \/	$T_{\rm C} = 25  ^{\circ}{\rm C}$ $T_{\rm C} = 100  ^{\circ}{\rm C}$		69	
	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	44	Α	
Pulsed drain current <sup>a</sup>			I <sub>DM</sub>	206		
Linear derating factor					4.2	W/°C
Single pulse avalanche energy b				E <sub>AS</sub>	1706	mJ
Maximum power dissipation			P <sub>D</sub>	520	W	
Operating junction and storage temperature range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Reverse diode dv/dt <sup>d</sup>				dv/dt	3.2	V/ns
Soldering recommendations (peak temperatur	e) <sup>c</sup>	For 10 s			260	°C

#### **Notes**

- Initial samples marked as SiHG73N60BE
- a. Repetitive rating; pulse width limited by maximum junction temperature
- b.  $V_{DD}$  = 120 V, starting  $T_J$  = 25 °C, L = 28.2 mH,  $R_q$  = 25  $\Omega$ ,  $I_{AS}$  = 11 A
- c. 1.6 mm from case
- d.  $I_{SD} \le I_D$ , di/dt = 60 A/ $\mu$ s, starting  $T_J$  = 25 °C

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	SYMBOL TYP. MAX.		UNIT		
Maximum junction-to-ambient	R <sub>thJA</sub>	-	40	°C/W		
Maximum junction-to-case (drain)	R <sub>thJC</sub>	-	0.24	G/ VV		



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PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static					•	•	
Drain-source breakdown voltage	V <sub>DS</sub>	V <sub>GS</sub> =	600	-	-	V	
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	Referenc	-	0.46	-	V/°C	
Gate-source threshold voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	2.0	-	4.0	V	
Gate-source leakage		V <sub>GS</sub> = ± 20 V		-	-	± 100	nA
Gate-Source leakage	I <sub>GSS</sub>	\	$V_{GS} = \pm 30 \text{ V}$		-	± 1	μΑ
Zero gate voltage drain current		V <sub>DS</sub> =	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V		-	1	
zero gate voltage drain current	I <sub>DSS</sub>	$V_{DS} = 480 \text{ V}$	, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	100	μA
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 36.5 A	-	0.035	0.042	Ω
Forward transconductance <sup>a</sup>	g <sub>fs</sub>	V <sub>DS</sub> = 40 V, I <sub>D</sub> = 36.5 A		-	28	-	S
Dynamic							
Input capacitance	C <sub>iss</sub>	$V_{GS} = 0 V$ ,		-	6709	-	pF
Output capacitance	Coss	,	$V_{DS} = 100 \text{ V},$		282	-	
Reverse transfer capacitance	$C_{rss}$	f = 1 MHz		-	7	-	
Effective output capacitance, energy related <sup>a</sup>	C <sub>o(er)</sub>	$V_{DS} = 0 \text{ V to } 480 \text{ V}, V_{GS} = 0 \text{ V}$		-	181	-	
Effective output capacitance, time related <sup>b</sup>	$C_{o(tr)}$			-	888	-	
Total gate charge	Qg			-	171	342	
Gate-source charge	$Q_{gs}$	V <sub>GS</sub> = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 36.5 \text{ A}, V_{DS} = 480 \text{ V}$		34	-	nC
Gate-drain charge	$Q_{gd}$				57	-	
Turn-on delay time	t <sub>d(on)</sub>	V <sub>DD</sub> = 480 V, I <sub>D</sub> = 36.5 A,		1	51	102	- ns
Rise time	t <sub>r</sub>			ı	80	160	
Turn-off delay time	$t_{d(off)}$	V <sub>GS</sub> =	$V_{GS} = 10 \text{ V}, R_g = 10 \Omega$		244	488	
Fall time	t <sub>f</sub>			-	104	208	
Gate input resistance	$R_g$	f = 1 MHz, open drain		0.3	0.7	1.5	Ω
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous source-drain diode current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	68	
Pulsed diode forward current	I <sub>SM</sub>			-	-	206	A
Diode forward voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 36.5 A, V <sub>GS</sub> = 0 V		-	-	1.2	V
Reverse recovery time	t <sub>rr</sub>				479	958	ns
Reverse recovery charge	Q <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = I_S = 36.5 \text{ A},$ di/dt = 100 A/ $\mu$ s, $V_R = 400 \text{ V}$		-	11	22	μC
Reverse recovery current	I <sub>RRM</sub>			-	42	-	Α

#### Notes

a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$  b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ 



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

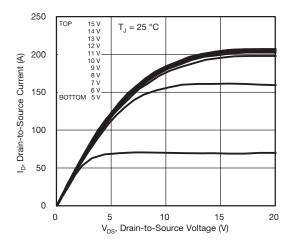


Fig. 1 - Typical Output Characteristics

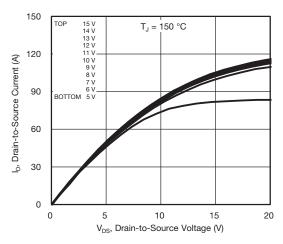


Fig. 2 - Typical Output Characteristics

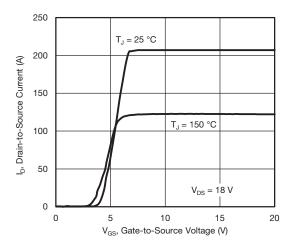


Fig. 3 - Typical Transfer Characteristics

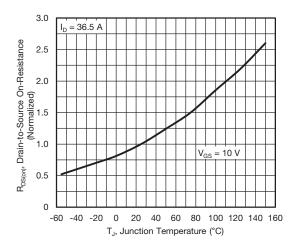


Fig. 4 - Normalized On-Resistance vs. Temperature

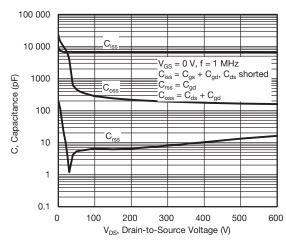


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

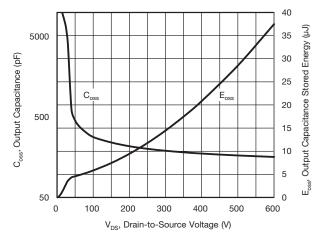


Fig. 6 - Coss and Eoss vs. VDS



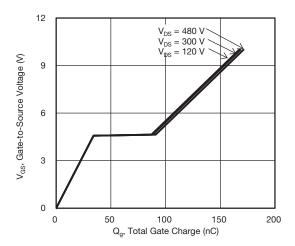


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

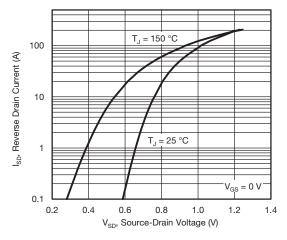


Fig. 8 - Typical Source-Drain Diode Forward Voltage

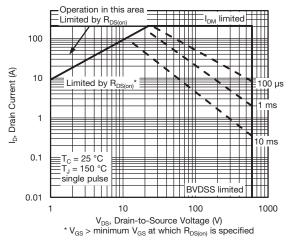


Fig. 9 - Maximum Safe Operating Area

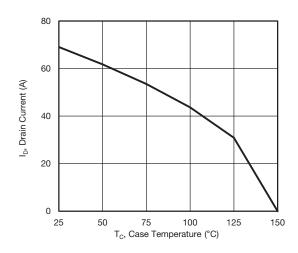


Fig. 10 - Maximum Drain Current vs. Case Temperature

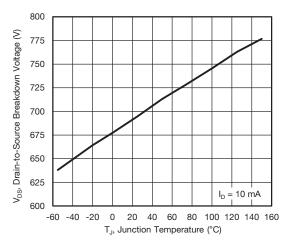


Fig. 11 - Temperature vs. Drain-to-Source Voltage



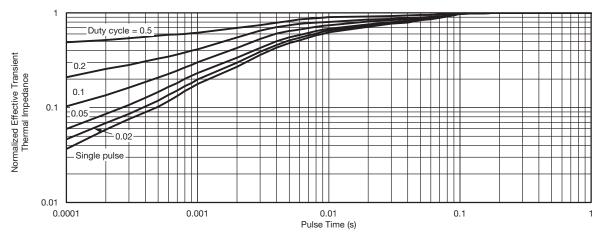


Fig. 12 - Normalized Transient Thermal Impedance, Junction-to-Case

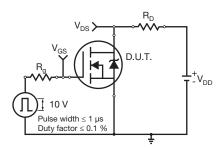


Fig. 13 - Switching Time Test Circuit

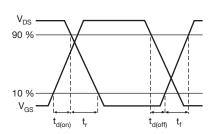


Fig. 14 - Switching Time Waveforms

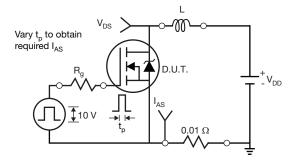


Fig. 15 - Unclamped Inductive Test Circuit

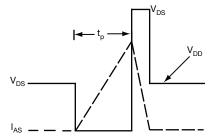


Fig. 16 - Unclamped Inductive Waveforms

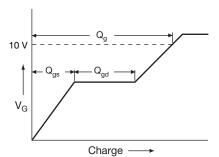


Fig. 17 - Basic Gate Charge Waveform

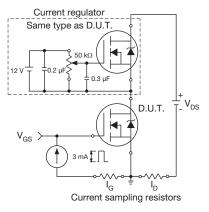
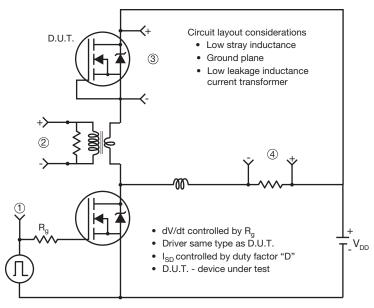


Fig. 18 - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



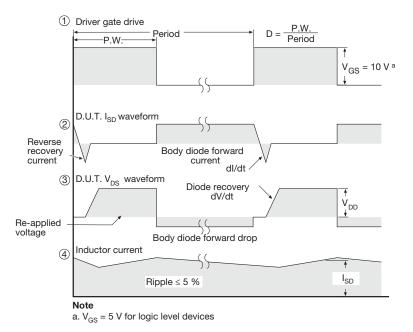


Fig. 19 - For N-Channel

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